## Applicant(s)/Patent Under Application/Control No. Reexamination 10/501,201 CHO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2821 **Tuyet Vo U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0097203 07-2002 Onozawa et al. 345/67 Α US-В US-С US-D Ε US-F US-US-G US-Н USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s ı **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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